

SIDC09D60E6

Fast switching diode chip in EMCON-Technology

FEATURES:

- 600V EMCON technology 70 µm chip
- soft , fast switching
- low reverse recovery charge
- small temperature coefficient

This chip is used for:

• EUPEC power modules and discrete devices



 Applications:
SMPS, resonant applications, drives

Chip Type	V _R	IF	Die Size	Package	Ordering Code
SIDC09D60E6	600V	20A	3 x 3 mm ²	sawn on foil	Q67050-A4006- A001

MECHANICAL PARAMETER:

Raster size	3 x 3			
Area total / active	9 / 6.7	mm ²		
Anode pad size	2.51 x 2.51			
Thickness	70	μm		
Wafer size	150	mm		
Flat position	180	deg		
Max. possible chips per wafer	1667 pcs			
Passivation frontside	Photoimide			
Anode metallisation	3200 nm AlSiCu			
Cathode metallisation	1400 nm Ni Ag –system suitable for epoxy and soft solder die bonding			
Die bond	electrically conductive glue or solder			
Wire bond	AI, ≤500µm			
Reject Ink Dot Size	Ø 0.65mm ; max 1.2mm			
Recommended Storage Environment	store in original container, in dry nitrogen, < 6 month at an ambient temperature of 23°C			



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Maximum Ratings

Parameter	Symbol	Condition	Value	Unit	
Repetitive peak reverse voltage	V _{RRM}		600	V	
Continuous forward current limited by T _{jmax}	/ _F		20		
Single pulse forward current (depending on wire bond configuration)	I _{FSM}	$t_P = 10 \text{ ms sinusoidal}$ $T_j = 25^{\circ}C$	80	A	
Maximum repetitive forward current limited by T _{jmax}	I _{FRM}		60]	
Operating junction and storage temperature	T_{j} , T_{stg}		-55+150	°C	

Static Electrical Characteristics (tested on chip), T_j =25 °C, unless otherwise specified

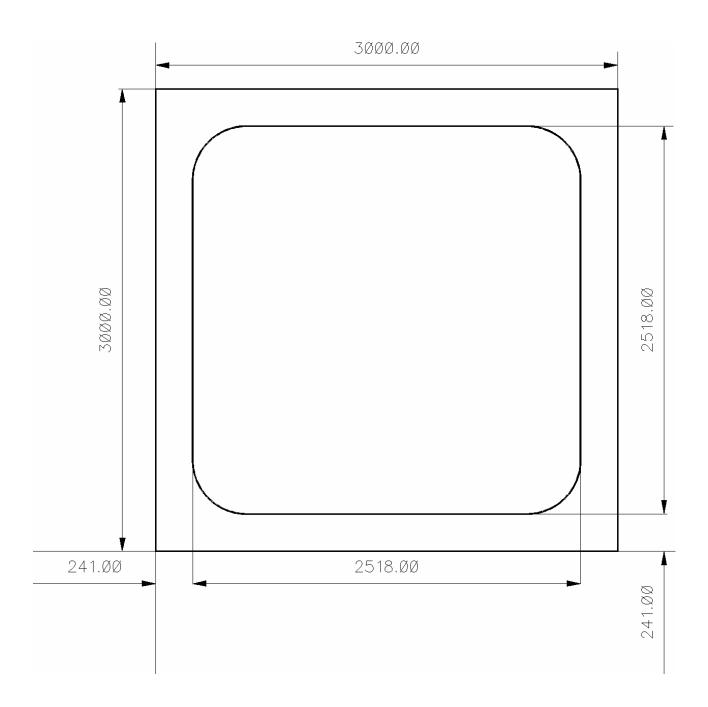
Parameter	Symbol	Cond	Value			Unit	
Falameter		Conditions		min.	Тур.	max.	
Reverse leakage current	I _R	V _R =600V	<i>T_j</i> =25 ° <i>C</i>			27	μA
Cathode-Anode breakdown Voltage	V _{Br}	I _R =3mA	<i>T_j</i> =25°C	600			V
Forward voltage drop	V _F	I _F =20A	<i>T_j</i> =25 ° <i>C</i>	-	1.25	1.7	V

Dynamic Electrical Characteristics, at T_j = 25 °C, unless otherwise specified, tested at component

Parameter	Symbol	Conditions -		Value			Unit
	Symbol			min.	Тур.	max.	
Reverse recovery time	t _{rr1}	<i>I_F=20A</i> <i>di/dt=700A/m</i> s	$T_j = 25 °C$		150		ns
	t _{rr2}	$V_R=400V$	$T_j = 125 ^{\circ}C$		200		
Peak recovery current	I _{RRM1}	I _F =20A	$T_j = 25 °C$		20		A
	I _{RRM2}	di/dt=900A/ms $V_R=300V$	$T_j = 125 ^{\circ}C$		25		
Reverse recovery charge	Q _{rr1}	I _F =20A	<i>T_j</i> =25°C		1.7		μC
	Q _{rr2}	di/dt=900A/ms $V_R=300V$	<i>T_j</i> =125°C		2.7		μU



CHIP DRAWING:





FURTHER ELECTRICAL CHARACTERISTICS:

This chip data sheet refers to the	INFINEON TECHNOLOGIES /	tbd
device data sheet	EUPEC	lbu

Description:

AQL 0,65 for visual inspection according to failure catalog

Electrostatic Discharge Sensitive Device according to MIL-STD 883

Test-Normen Villach/Prüffeld

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